

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

Centro Integral de Metrología, S.A. de C.V.

Av. Circunvalación # 3829, Col. Nuevo San Rafael Guadalupe, Nuevo León, México C.P. 67110

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Dimensional, Mass, Force and Weighing Devices, Mechanical, Volume, Time and Frequency, Chemical, Thermodynamic and Electrical Calibration
(As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

 ${\it Initial\ Accreditation\ Date:}$

Issue Date:

Expiration Date:

December 13, 2010

January 28, 2021

March 31, 2023

Accreditation No.:

Certificate No.:

Tracy Szerszen President

66573

L21-70

Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: www.pjlabs.com





Centro Integral de Metrología, S.A. de C.V.

Av. Circunvalación # 3829, Col Nuevo San Rafael Guadalupe, Nuevo León, México C.P. 67110 Contact Name: Guillermo Prieto Flores Phone: 818-479-1354

Accreditation is granted to the facility to perform the following calibrations:

Dimensional

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Calipers ^F	1 mm to 1 500 mm	$(5.5 + 0.076L) \mu m$	Gage Blocks Grade 0 NMX-CH-002-IMNC
Depth Gauges ^F	1 mm to 300 mm	$(5.5 + 0.076L) \mu m$	
Outside Micrometers ^F	1 mm to 600 mm	$(2 + 0.017L) \mu m$	JIS B 7507 NMX-CH-099-IMNC
Inside Micrometers ^F	40 mm to 600 mm	$(2.2 + 0.017L) \mu m$	JIS B 7502
Depth Micrometers ^F	1 mm to 300 mm	$(2.1 + 0.017L) \mu m$	ASME B89.1.9
Height Master ^F	10 mm to 600 mm	2.9 μm	JIS B 7502 Thickness Gage Films
End Measuring Rods (Standards) ^F	25 mm to 300 mm	(0.9 + 0.018L) μm	(Fabricant Manual)
Micrometer Heads ^F	2.5 mm to 50 mm	3 μm	
Ultrasonic Thickness Gauge ^F	10 mm to 200 mm	25 μm	
Height Gauges ^F	0.5 mm to 1 000 mm	12 μm	Thickness Gage Films JIS B 7517
Indicators ^F	1 mm to 50 mm	$(4.8 + 0.005L) \mu m$	Electronic Head
Test Indicator ^F	0.1 mm to 1.5 mm	2 μm	Micrometer JIS B 7503
Microscopes ^F	200 mm to 100 mm	4.5 μm	Glass Scale, Reticule JIS B 7153
Tape Measures Error of Indication ^F	1 m to 20 m	(0.21 + 0.035L) mm	Length Standard NMX-CH-0148-IMNC
Granite Surface Plates Repeat Measurement ^O	0.05 mm	1.3 μm	Repeat-O-Meter Rahn with Micro indicator ASME B89.3.7
Optical Comparators X axis Linearity Y axis Linearity ⁰	1 mm to 200 mm 1 mm to 200 mm	7.6 μm 7.6 μm	Glass Scale, Gage Blocks JIS B 7184
Optical Comparators Axial Orientation ^O	At 100 mm Y Axis Travel	0.01°	Glass Scale JIS B 7184
Optical Comparators	10X	0.05 %	Magnification Sphere
Magnification ^O	20X	0.03 %	Standards / Glass Scale
	50X	0.03 %	JIS B 7184
	100X	0.03 %	
Optical Comparators Angularity ^O	0° to 90°	0.05°	Reticule JIS B 7184
Bore Gauges ^F	10 mm to 150 mm	7 μm	Super Micrometer
Pin Gauges ^F	0.5 mm to 25.4 mm	0.6 μm	ASME B89.1.6
Plain Plug Gauges ^F	0.5 mm to 100 mm	1.5 μm	





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Issue: 01/2021

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Snap Gauge Go / No Go ^F	12 mm to 100 mm	1.7 μm	Super Micrometer ASME B89.1.6
Setting Rings ^F	12 mm to 200 mm	1.6 μm	Micro Indicator with (Res.= 0.026 μm) ASME B89.1.6
Thread Gauges Pitch Diameter ^F	0-80 to 4-12	120 μin	Super Micrometer Thread Wires Set ASME B1.2 ASME B1.16M
Surface Roughness Ra Fixed Point ^F	2.97 μm	0.13 μm	Ra Roughness Master ISO 5436-1
Surface Roughness Ry Fixed Point ^F	9.4 μm	0.15 μm	

Mass, Force and Weighting Devices

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Analytical Balances ^O	1 g to 200 g (Res.= 0.000 1g)	$(1.1 \times 10^{-3} + 1.8 \times 10^{-6} \text{Wt}) \text{ g}$	Class F1 Weights NOM-010-SCFI
Lab Balances ^O	201 g to 10 000 g (Res.= 0.001 g)	$(5 \times 10^{-3} + 5.73 \times 10^{-6} \text{Wt}) \text{ g}$	
Bench Scales ^O	10 001 g to 50 kg (Res.= 0.002 g)	$(3 \times 10^{-3} + 4 \times 10^{-5} \text{Wt}) \text{ g}$	Class M1 Weights NOM-010-SCFI
Platform Scales ^O	51 kg to 500 kg (Res.= 0.02 kg)	$(1 + 3 \times 10^{-5} \text{Wt}) \text{ kg}$	Class M2 Weights NOM-010-SCFI
Floor Scales ^o	501 kg to 3 000 kg (Res.= 0.1 kg) 3 001 kg to 4 000 kg (Res.= 0.2 kg)	$(1 + 4.5 \times 10^{-5} \text{Wt}) \text{ kg}$ 210 g	
	4 001 kg to 5 000 kg (Res.= 0.2 kg)	220 g	
	5 001 kg to 10 000 kg (Res.= 1 kg)	1.5 kg	
	10 001 kg to 20 000 kg (Res.= 2 kg)	1.9 kg	
	20 001 kg to 100 000 kg (Res.= 2 kg)	8 kg	
Mass - Class M1	1 mg	0.04 mg	Class F1 Weights
Fixed Points ^F	2 mg	0.04 mg	OIML R 111



Issue: 01/2021



Certificate of Accreditation: Supplement

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Mass, Force and Weighting Devices

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Mass - Class M1	5 mg	0.04 mg	Class F1 Weights
Fixed Points ^F	10 mg	0.04 mg	OIML R 111
	20 mg	0.07 mg	
	50 mg	0.1 mg	
	100 mg	0.13 mg	
	200 mg	0.17 mg	
	500 mg	0.23 mg	
	1 g	0.27 mg	
	2 g	0.3 mg	
	5 g	0.3 mg	
	10 g	0.55 mg	
	20 g	0.55 mg	
	50 g	0.73 mg	
	100 g	1.3 mg	
	500 g	6.1 mg	
	1 kg	12 mg	
	2 kg	/25 mg	
	5 kg	64 mg	
	10 kg	0.15 g	
	20 kg	0.25 g	
	25 kg	0.25 g	
Mass - Class M2	1 mg	0.04 mg	
Fixed Points ^F	2 mg	0.04 mg	
	5 mg	0.04 mg	
	10 mg	0.04 mg	
	20 mg	0.07 mg	
	50 mg	0.1 mg	
	100 mg	0.13 mg	
	200 mg	0.17 mg	
	500 mg	0.23 mg	
	1 g	0.27 mg	
	2 g	0.3 mg	





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Mass, Force and Weighting Devices

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Mass - Class M2	5 g	0.3 mg	Class F1 Weights
Fixed Points ^F	10 g	0.55 mg	OIML R 111
	20 g	0.55 mg	
	50 g	0.73 mg	
	100 g	1.3 mg	
	500 g	6.1 mg	
	1 kg	12 mg	
	2 kg	25 mg	
	5 kg	64 mg	
	10 kg	0.15 g	
	20 kg	0.25 g	
	25 kg	0.25 g	
Mass Class M2 and M3	500 kg	47 g	Class M1 Weights
Fixed Points ^F	1 000 kg	65 g	OIML R 111

Mechanical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Force Measurement	1 kN to 10 kN	0.3 % of reading	Load Cells PT
Instrument Tensile and	10 kN to 50 kN	0.35 % of reading	ISO 7500/1
Compression ^O	50 kN to 98.06 kN	0.35 % of reading	
	98.06 kN to 196 kN	0.4 % of reading	
	196 kN to 294 kN	0.4 % of reading	
Dynamometer ^F	1 N to 10 N	0.25 % of reading	Class F1 Weights ISO 7500/1
	10 N to 100 N	0.27 % of reading	Class M1 Weights ISO 7500/1
	100 N to 1 000 N	0.3 % of reading	Load Cells ISO 7500/1
Torque Meter ^F	0.1 N·m to 11.3 N·m	0.7 % of reading	Torque Analyzer
	11.3 N·m to 33.9 N·m	0.7 % of reading	Sturtevant Richmont
	33.9 N⋅m to 108 N⋅m	1 % of reading	System 4 ISO 6789
	108 N⋅m to 203 N⋅m	1 % of reading	





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Mechanical

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Torque Meter ^F	203 N⋅m to 338.9 N⋅m	1 % of reading	Torque Analyzer
	338.9 N·m to 813 N·m	1 % of reading	Sturtevant Richmont System 4 ISO 6789
	813 N·m to 1 355 N·m	1 % of reading	150 6/89
Indirect Verification of	20 HRC to 39 HRC	0.45 HRC	ASTM E-18
Rockwell Hardness Testers HRC ^O	40 HRC to 59 HRC	0.42 HRC	Rockwell Hardness Test Block
Testers fixes	60 HRC to 70 HRC	0.4 HRC	
Indirect Verification of	40 HRB to 59 HRB	0.95 HRB	
Rockwell Hardness Testers HRB ^o	60 HRB to 80 HRB	0.7 HRB	
Testers HKB	81 HRB to 100 HRB	0.45 HRB	
Indirect Verification of	70 HR15N to 77 HR15N	0.33 HR15N	
Rockwell Hardness Testers HR15N ^O	78 HR15N to 88 HR15N	0.33 HR15N)
Testers HRISIN°	89 HR15N to 91 HR15N	0.3 HR15N	/
Indirect Verification of	42 HR30N to 54 HR30N	0.51 HR30N	
Rockwell Hardness Testers HR30N ^O	55 HR30N to 73 HR30N	0.3 HR30N	
Testers HR30IN°	74 HR30N to 80 HR30N	0.3 HR30N	
Indirect Verification of	75 HR15T to 80 HR15T	0.79 HR15T	ASTM E-18
Rockwell Hardness Testers HR15T ^O	81 HR15T to 87 HR15T	0.79 HR15T	Rockwell Hardness Test Block
Testers HK151°	88 HR15T to 93 HR15T	0.79 HR15T	
Indirect Verification of	43 HR30T to 56 HR30T	0.61 HR30T	
Rockwell Hardness Testers HR30T ^O	57 HR30T to 69 HR30T	0.32 HR30T	
Testers HR301°	70 HR30T to 82 HR30T	0.32 HR30T	
Indirect Verification of Brinell Hardness Tester HBW 10/3 000 ^o	92.5 HBW to 650 HBW	3.8 HBW	ASTM E-10 Brinell Hardness Test Block
Indirect Verification of Brinell Hardness Tester HBW 10/500°	92.5 HBW to 125 HBW	1.5 HBW	
Indirect Verification of Micro Hardness Tester Vickers ^O	100 HV to 900 HV	15 HV	ASTM E384 Micro Hardness Test Block
Indirect Verification of Micro Hardness Tester Knoop ^o	100 HK to 900 HK	17 HK	





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Mechanical

Mechanical	T =	T	T
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Vaccum ^F	-76 cm/Hg to -0.1 cm/Hg	0.07 cm/Hg	Vacuum Calibrator Fluke
			718 1G Vacuum Module
			Fluke 700PV4
			Euramet-cg-17
Pressure ^F	1 psi to 100 psi	1 % of reading	Pressure Calibrator Meriam
	100 psi to 1 000 psi	1 % of reading	MH-10KT and
	1 000 psi to 2 000 psi	1 % of reading	MGF16BN-10 000 psig Pressure Transducer
	2 000 psi to 5 000 psi	1 % of reading	ASME B-40-1
	5 000 psi to 10 000 psi	1 % of reading	
Rotational Viscometers ^F	0.01 Pa·s to 100 Pa·s	2.2 % of reading	Visco Standards ASTM D 445
Direct Verification of Durometer Hardness Tester Types A, B, C, D, E, O & DO Extension at zero reading	2.46 mm to 2.54 mm	7.4 µm	ASTM D-2240 Electronic Head
Indentor Shape (Not all parameters apply to all of Durometer Types)			Micrometer
Indentor Diameter		7.4 μm	Video Comparator 20x
Indentor Tip Diameter		7.4 μm	Video Comparator 20x
Indentor Tip Radius Indentor Tip Angle		7.4 μm 0.06°	Video Comparator 20x Video Comparator 20x
Durometer Indentor Spring Types A, B, E & O	0.55 N to 8.05 N	1.4 N	Electronic Balance
Types C, D & DO ^F	4.445 N to 44.45 N	1.4 N	Electronic Balance

Chemical

Chemical			
MEASURED INSTRUMENT,	RANGE OR NOMINAL DEVICE	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	SIZE AS APPROPRIATE	MEASUREMENT	EQUIPMENT
		CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
pH Meters -	4 pH	0.02 pH	pH Buffer Solution
Probe Calibration Fixed Points ^F	7 pH	0.02 pH	Technical Guide CENAM
rixed Points	10 pH	0.02 pH	





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Chemical

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Conductivity Meter -	10 μS/cm to 100 μS/cm	1.2 % of reading	Conductivity Calibration
Probe Calibration	100 μS/cm to 10 000 μS/cm	1.3 % of reading	Solutions
Fixed Point ^F	10 000 μS/cm to 100 000 μS/cm	1.3 % of reading	Technical Guide CENAM
Kinematic Viscosity Zahn ^F	166.5 mm ² /s	1 % of reading	Cannon Standard Oil
Cups No. 2 @ 20 °C			ASTM D4212
Kinematic Viscosity Ford F	166.5 mm ² /s	1 % of reading	Cannon Standard Oil
Cups No. 3, 4 @20 °C		_	ASTM D4212

Thermodynamic

Thermoughanne			
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Bimetallic Thermometers ^F	-15 °C to 100 °C	0.3 °C	Thermocouple Output
	100 °C to 350 °C	0.5 °C	Escort 22
			Euramet-cg-8
Infrared Non-Contact	-15 °C to 450 °C	2.1 °C	Infrared Calibrator
Thermometers ^F	450 °C to 900 °C	2.3 °C	Technical Guide CENAM
Relative Humidity ^F	35 % RH	1.6 % RH	Thermohygrometer Extech
@20 °C	75 % RH	1.6 % RH	Saturated Salt Solution Cabinet Technical Guide CENAM
	97 % RH	1.7 % RH	Technical Guide CENAM

Volume

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Pipettes ^F	1 mL	2.9 μL	Balance BEM-220
Fixed Volume Precision	5 mL	2.9 μL	Technical Guide CENAM
	10 mL	3.3 μL	
	25 mL	4.9 μL	
Burette ^F	10 mL	11 μL	
	25 mL	29 μL	
	50 mL	47 μL	
Graduated Cylinder ^F	25 mL to 2 000 mL	0.9 mL	Balance Radwag PS1000R1
Volumetric Flask ^F	50 mL to 2 000 mL	0.01 mL	Technical Guide CENAM
Containers ^F	10 L to 200 L	0.29 mL	Balance Mettler Toledo XA32001L Technical Guide CENAM





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Time & Frequency

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Tachometer ^{FO}	1 rpm to 10 000 rpm	2 % of reading	Tachometer Generator RPM Central Machinery with Control Hanyoung Technical Guide CENAM
Stopwatch ^{FO}	60 s to 86 400 s	0.5 s/day	Direct Comparation Stopwatch, UTC NIST SP-960-12

Electrical

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Temperature Calibration, Indication and Control Equipment used with	315.6 °C to 550 °C	2.2 °C	Escort 22
	550 °C to 900 °C	1.6 °C	Electrical Simulation of Thermocouple Output
Thermocouple Type B ^F	900 °C to 1 150 °C	1.2 ℃	Euramet cg-11
1 31	1 150 °C to 1 820 °C	1.1 ℃	
Temperature Calibration,	-240 °C to -200 °C	0.8 °C	
Indication and Control	-200 °C to -100 °C	0.4 °C	
Equipment used with Thermocouple Type E ^F	-100 °C to 850 °C	0.3 °C	
	850 °C to 1 000 °C	0.4 °C	
Temperature Calibration,	-210 °C to -180 °C	0.6 °C	
Indication and Control	-180 °C to -50 °C	0.4 °C	
Equipment used with Thermocouple Type J ^F	50 °C to 500 °C	0.2 °C	
Incime couple Type t	500 °C to 1 200 °C	0.4 °C	
Temperature Calibration,	-230 °C to -100 °C	0.8 °C	
Indication and Control	-100 °C to 1 050 °C	0.4 °C	
Equipment used with Thermocouple Type K ^F	1 050 °C to 1 371.1 °C	0.6 °C	
Temperature Calibration,	-200 °C to -50 °C	0.4 °C	
Indication and Control	-50 °C to 500 °C	0.2 °C	
Equipment used with Thermocouple Type L ^F	500 °C to 750 °C	0.3 °C	
Temperature Calibration,	-230 °C to -180 °C	1.5 °C	
Indication and Control Equipment used with	-180 °C to -50 °C	1 ℃	
Thermocouple Type N ^F	-50 °C to 1 100 °C	0.4 °C	
1 71	1 100 °C to 1 300 °C	0.6 °C	





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Temperature Calibration,	-18.3 °C to 250°C	1.6 °C	Escort 22
Indication and Control	250 °C to 750 °C	1.2 ℃	Electrical Simulation of
Equipment used with Thermocouple Type R ^F	750 °C to 1 600 °C	1 °C	Thermocouple Output Euramet cg-11
1 71	1 600 °C to 1 767.8 °C	1.2 ℃	
Temperature Calibration,	-18.3 °C to 100 °C	1.8 ℃	
Indication and Control	100 °C to 400 °C	1.4 °C	
Equipment used with Thermocouple Type S ^F	400 °C to 1 700 °C	1.2 °C	
	1 700 °C to 1 767.8 °C	1.4 °C	
Temperature Calibration,	-260 °C to -200 °C	1.5 ℃	
Indication and Control	-200 °C to -50 °C	0.8 °C	
Equipment used with Thermocouple Type T ^F	-50 °C to 0 °C	0.4 °C	
Thermocoupie Type T	0 °C to 400 °C	0.2 °C	
Temperature Calibration,	-200 °C to -75 °C	0.6 °C	
Indication and Control	-75 °C to 100 °C	0.4 °C	
Equipment used with Thermocouple Type U ^F	100 °C to 6 200 °C	0.2 °C	
Temperature Calibration,	-200 °C to 0 °C	0.2 °C	Fluke 743B
Indication and Control	0 °C to 630 °C	0.3 °C	Electrical Simulation of
Equipment used with RTD Type Pt 3 926, $100 \Omega^F$			RTD Output Euramet cg-11
Temperature Calibration,	-200 °C to 0 °C	0.2 °C	Euramet eg-11
Indication and Control	0 °C to 400 °C	0.3 °C	
Equipment used with RTD	400 °C to 800 °C	0.6 °C	
Type Pt 385, $100 \Omega^{F}$ Temperature Calibration,	-200 °C to -190 °C	0.4 °C	
Indication and Control	-190 °C to 0 °C	0.2 °C	
Equipment used with RTD	0 °C to 360 °C	0.3 °C	
Type Pt 3 916, $100 \Omega^F$ Temperature Calibration,	-200 °C to 0 °C	0.2 °C	-
Indication and Control	0 °C to 100 °C	0.2 °C	
Equipment used with RTD	100 °C to 260 °C	0.3 °C	
Type Ni 672, 120 Ω^F Temperature Calibration,	-200 °C to 0 °C	0.2 °C	
Indication and Control			
Equipment used with RTD	0 °C to 400 °C	0.3 °C	
Type Pt 385, 200 Ω ^F	400 °C to 630 °C	0.4 °C	





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Electrical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Temperature Calibration,	-200 °C to 0 °C	0.2 °C	Fluke 743B
Indication and Control	0 °C to 400 °C	0.3 °C	Electrical Simulation of
Equipment used with RTD Type Pt 385, 500 Ω^F	400 °C to 630 °C	0.4 °C	RTD Output Euramet cg-11
Temperature Calibration,	-200 °C to 0 °C	0.2 °C	
Indication and Control	0 °C to 400 °C	0.3 °C	
Equipment used with RTD Type Pt 385, 1 000 Ω^F	400 °C to 630 °C	0.4 °C	
Temperature Calibration,	-100 °C to 0 °C	1.1 °C]
Indication and Control	0 °C to 260 °C	1.4 °C	
Equipment used with RTD Type Cu 427, $10 \Omega^F$			
Equipment to Measure	1 mV to 99 mV	0.005 % of reading + 0.003 5 mV	Agilent 34001A
DC Voltage ^F	100 mV to 0.99 V	0.004 % of reading + 0.000 7 mV	Multimeter
	1 V to 9.99 V	0.003 5 % of reading + 0.000 5 mV	Procedure CNMII-ELE-001
	10 V to 99.9 V	0.004 5 % of reading + 0.000 6 mV	
	100 V to 1 000 V	0.004 5 % of reading + 0.001 V	
Equipment to Measure AC Voltage At the listed frequencies ^F		100	Agilent 34001A Multimeter Procedure CNMII-ELE-001
3 Hz to 5 Hz	10 mV to 100 mV	1 % of reading + 0.04 mV	
5 Hz to 10 Hz	10 mV to 100 mV	0.35 % of reading + 0.04 mV	
10 Hz to 20 kHz	10 mV to 100 mV	0.06 % of reading + 0.04 mV	
20 kHz to 50 kHz	10 mV to 100 mV	0.12 % of reading + 0.04 mV]
50 kHz to 100 kHz	10 mV to 100 mV	0.6 % of reading + 0.08 mV	1
100 kHz to 300 kHz	10 mV to 100 mV	4 % of reading + 0.5 mV	
3 Hz to 5 Hz	100 mV to 1 V	1 % of reading + 0.03 V]
5 Hz to 10 Hz	100 mV to 1 V	0.35 % of reading + 0.03 V	1
10 Hz to 20 kHz	100 mV to 1 V	0.06 % of reading + 0.03 V	1
20 kHz to 50 kHz	100 mV to 1 V	0.12 % of reading + 0.04 V]
50 kHz to 100 kHz	100 mV to 1 V	0.6 % of reading + 0.08 V]
100 kHz to 300 kHz	100 mV to 1 V	4 % of reading + 0.5 V	1
Equipment to Measure AC Current At the listed frequencies ^F			
3 Hz to 5 Hz	1 V to 750 V	1 % of reading + 0.03 V	





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Av. Circunvalación # 3829, Col Nuevo San Rafael Guadalupe, Nuevo León, México. C.P. 67110 Contact Name Guillermo Prieto Flores Phone: 818-479-1354

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Electrical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Equipment to Measure AC Current At the listed frequencies ^F			Agilent 34001A Multimeter Procedure CNMII-ELE-001
5 Hz to 10 Hz	1 V to 750 V	0.35 % of reading + 0.03 V	
10 Hz to 20 kHz	1 V to 750 V	0.06 % of reading + 0.03 V	
20 kHz to 50 kHz	1 V to 750 V	0.12 % of reading + 0.04 V	
50 kHz to 100 kHz	1 V to 750 V	0.6 % of reading + 0.08 V	
100 kHz to 300 kHz	1 V to 750 V	4 % of reading + 0.5 V	
Equipment to Measure AC Current At the listed frequencies ^F			
3 Hz to 5 Hz	1 mA to 0.999 99 A	1 % of reading + 0.04 A	
5 Hz to 10 Hz	1 mA to 0.999 99 A	0.3 % of reading + 0.04 A	
10Hz to 5 kHz	1 mA to 0.999 99 A	0.1 % of reading + 0.04 A	
Equipment to Measure AC Current At the listed frequencies ^F			
3 Hz to 5 Hz	1 A to 3 A	1 % of reading + 0.04 A	
5 Hz to 10 Hz	1 A to 3 A	0.3 % of reading + 0.04 A	
10Hz to 5 kHz	1 A to 3 A	0.1 % of reading + 0.04 A	
Equipment to Measure	Up to 100 Ω	0.01 % of reading + 0.004 Ω	
Resistance ^F	100 Ω to 1 000 Ω	0.01% of reading + 0.001Ω	
	$1 \text{ k}\Omega \text{ to } 10 \text{ k}\Omega$	0.01% of reading + $0.001 \text{ k}\Omega$	
	10 kΩ to 100 kΩ	0.01 % of reading + 0.001 k Ω	
	100 kΩ to 1 MΩ	0.01 % of reading + 0.001 M Ω	
	1 MΩ to 10 MΩ	0.04% of reading + 0.001 M Ω	
	10 MΩ to 100 MΩ	0.8% of reading + $0.01\ M\Omega$	
Equipment to Measure	3 Hz to 5 Hz	0.1 % of reading	
Frequency	5 Hz to 10 Hz	0.05 % of reading	
At the listed voltage (100 mV to 750 V) ^F	10 Hz to 40 Hz	0.03 % of reading	
(40 Hz to 300 Hz	0.01 % of reading	
Equipment to Output	1 mV to 1 V	0.05 % of reading	AC/DC V-A Source
DC Voltage ^F	1 V to 10 V	0.05 % of reading	Model 828
	10 V to 100 V	0.05 % of reading	Procedure CNMII-ELE-001
	100 V to 1 000 V	0.05 % of reading	





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Equipment to Output	1 mA to 1A	0.1 % of reading	AC/DC V-A Source
DC Current ^F	1 A to 10A	0.1 % of reading	Model 828 Procedure CNMII-ELE-001
Equipment to Output AC Voltage At the listed frequencies ^F			Procedure CNMII-ELE-001
50 Hz	1 mV to 32.999 mV	0.05 % of reading	
60 Hz	1 mV to 32.999 mV	1 % of reading	
400 Hz	1 mV to 32.999 mV	1 % of reading	
Equipment to Output AC Voltage At the listed frequencies ^F			
50 Hz	33 mV to 329.999 mV	0.05 % of reading	
60 Hz	33 mV to 329.999 mV	1 % of reading	
400 Hz	33 mV to 329.999 mV	1 % of reading	
Equipment to Output AC Voltage At the listed frequencies ^F			
50 Hz	0.33 mV to 3.299 99 mV	0.05 % of reading	
60 Hz	0.33 mV to 3.299 99 mV	1 % of reading	
400 Hz	0.33 mV to 3.299 99 mV	1 % of reading	
Equipment to Output AC Voltage At the listed frequencies ^F			
50 Hz	33 V to 329.999 V	0.5 % of reading	
60 Hz	33 V to 329.999 V	1 % of reading	
400 Hz	33 V to 329.999 V	1 % of reading	
Equipment to Output AC Voltage At the listed frequencies ^F			
50 Hz	3.3 V to 32.999 9 V	0.5 % of reading	
60 Hz	3.3 V to 32.999 9 V	1 % of reading	
400 Hz	3.3 V to 32.999 9 V	1 % of reading	
Equipment to Output AC Voltage At the listed frequencies ^F			
50 Hz	330 V to 1 000 V	0.5 % of reading	





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Equipment to Output			AC/DC V-A Source
AC Voltage			Model 828
At the listed frequencies ^F	330 V to 1 000 V	0.1 % of reading	Procedure CNMII-ELE-001
400 Hz	330 V to 1 000 V	0.1 % of reading	
Equipment to Output	330 V to 1 000 V	0.1 % of feating	
AC Current At the listed frequencies ^F			
50 Hz	0.029 mA to 0.329 99 mA	0.5 % of reading	
60 Hz	0.029 mA to 0.329 99 mA	0.1 % of reading	
400 Hz	0.029 mA to 0.329 99 mA	0.1 % of reading	
Equipment to Output AC Current At the listed frequencies ^F			
50 Hz	0.33 mA to 3.299 9 mA	0.05 % of reading	
60 Hz	0.33 mA to 3.299 9 mA	1 % of reading	
400 Hz	0.33 mA to 3.299 9 mA	1 % of reading	
Equipment to Output AC Current At the listed frequencies ^F		757	
50 Hz	3.3 mA to 32.999 mA	0.05 % of reading	
60 Hz	3.3 mA to 32.999 mA	1 % of reading	
400 Hz	3.3 mA to 32.999 mA	1 % of reading	
Equipment to Output AC Current At the listed frequencies ^F			
50 Hz	33 mA to 329.99 mA	0.05 % of reading	
60 Hz	33 mA to 329.99 mA	1 % of reading	
400 Hz	33 mA to 329.99 mA	1 % of reading	
Equipment to Output AC Current At the listed frequencies ^F			
50 Hz	0.33 A to 2.199 99 A	0.5 % of reading	
60 Hz	0.33 A to 2.199 99 A	0.1 % of reading	
400 Hz	0.33 A to 2.199 99 A	0.1 % of reading	





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MEASURED INSTRUMENT,	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Equipment to Output			AC/DC V-A Source
AC Current			Model 828
At the listed frequencies ^F			Procedure CNMII-ELE-001
50 Hz	2.2 A to 11 A	0.5 % of reading	
60 Hz	2.2 A to 11 A	0.1 % of reading	
400 Hz	2.2 A to 11 A	0.1 % of reading	

- 1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- 3. The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location. Example: Outside Micrometer^F would mean that the laboratory performs this calibration at its fixed location.
- 4. The presence of a superscript O means that the laboratory performs calibration of the indicated parameter onsite at customer locations. Example: Outside Micrometer of would mean that the laboratory performs this calibration onsite at the customer's location.
- 5. Measurement uncertainties obtained for calibrations performed at customer sites can be expected to be larger than the measurement uncertainties obtained at the laboratories fixed location for similar calibrations. This is due to the effects of transportation of the standards and equipment and upon environmental conditions at the customer site which are typically not controlled as closely as at the laboratories fixed location.
- 6. The term L represents length in inches or millimeters as appropriate to the uncertainty statement.
- 7. The term Wt represents weight in pounds or grams (including SI multiple and submultiple units) appropriate to the uncertainty statement